Form 1449 (Modified)	Atty Docket No.	101-P291/P3157US1
	Application No.:	10/687,534
Information Disclosure	Applicant	Kondrk et al.
Statement By Applicant	Filing Date	10/15/03
	Group	3627
(Use Several Sheets if Necessary)	Confirmation No.	7744

## U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
	A1.	2001/0021926 A1	09/2001	Schneck et al.			
	A2.	2001/0044786	11/22/2001	Ishibashi			
	A3.	2002/00002541 A1	01/2002	Williams		Ì	
	A4.	2002/0032658 A1	03/2002	Oki et al.			
	A5.	2002/0099661 A1	07/2002	Kii et al.			
	A6.	2002/0107803	08/2002	Lisanke et al.		Ì	
	A7.	2002/0112171	08/2002	Ginter et al.		1	
	A8.	2002/0116293	08/2002	Lao et al.		l	
	A9.	2002/0124182	09/2002	Basco et al.			
	A10.	2002/0152278	10/2002	Pontenzone et al.		İ	
	A11.	2002/0186844 A1	12/2002	Levy et al.		ı	
	A12.	2002/0198843 A1	12/2002	Wang et al.		ı	
	A13.	2003/0005173 A1	01/2003	Shah et al.		ı	
	A14.	2003/0115144 A1	06/2003	Stefik et al.			
	A15.	2003/0120593 A1	06/2003	Bansai et al.		ı	
	A16.	2004/0059929 A1	03/2004	Rodgers et al.		1	
	A17.	2004/0167858 A1	08/2004	Erickson			
	A18.	2004/0205028 A1	10/2004	Verosub et al.		i	
	A19.	2004/0215733 A1	10/2004	Gondhalekar et al.		Ī	
	A20.	2004/0254949	12/2004	Amirthalingam		ĺ	
	A21.	2004/0267552	12/2004	Gilliam et al.			
	A22.	2005/0038813	02/2005	Apparao et al.			
	A23.	2006/0015489	01/2006	Probst et al.			
	A24.	2006/0041748	02/2006	Lockhart et al.			

Examiner	Date Considered

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(Use Several Sheets if Necessary)	Confirmation No.	7744

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
	A25.	2006/0074754 A1	04/2006	Toyohara et al.			
	A26.	2006/0161604 A1	07/2006	Lobo		ĺ	
	A27.	2007/0011156	01/2007	Maron, Jonathan		İ	
	A28.	5,884,280 A	03/1999	Yoshioka et al.		i	
	A29.	6,263,313 B1	07/2001	Milsted et al.		ĺ	1
	A30.	7,209,892 B1	04/2007	Galuten et al.			

## Foreign Patent or Published Foreign Patent Application

Examiner		Document No.	Publication		Class	Sub-	Translation	
Initial			Date	Patent Office		Class	Yes No	)
	B1.							
	B2.							

## Other Documents

Examiner		
Initial	No.	Author, Title, Place (e.g. Journal) of Publication, Date
	C1.	
	C2.	
	C3.	

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